

WHAT IS CLAIMED IS:

1 1. An identification system comprising:
2 a plurality of identifiable elements;
3 a plurality of labels, each label associated with a unique or non-unique
4 identifiable element, the labels including reference markers and other markers, the labels
5 generating spectra in response to excitation energy; and
6 an analyzer for identifying the elements from the spectra of the associated
7 labels, the analyzer calibrating the spectra using reference signals generated by the
8 reference markers.

1 2. The identification system of claim 1, wherein the labels comprise
2 semiconductor nanocrystals.

1 3. The identification system of claim 2, wherein each reference
2 marker comprises at least one reference semiconductor nanocrystal.

1 4. The identification system of claim 3, wherein the reference markers
2 comprise a plurality of reference semiconductor nanocrystals, the reference markers of
3 each label generating a reference signal at a reference wavelength with a reference
4 intensity.

1 5. The identification system of claim 4, wherein the other markers
2 comprise other semiconductor nanocrystals generating other signals at other wavelengths
3 and with other intensities.

1 6. The identification system of claim 1, wherein the other markers
2 comprise code signal markers which generate code signals different than the reference
3 signals, the spectra comprising the marker signals and the code signals, and wherein, for
4 at least one label, the analyzer discretely quantifies the code signals emitted by the code
5 signal markers of the label by comparison of the code signals with the reference signal
6 and by selecting signal characteristics of the code signals from among a plurality of
7 discrete, predetermined signal characteristics.

1 7. The identification system of claim 6, wherein the reference signal
2 of each label has a reference intensity, and wherein the code signals of the label have

code signal intensities, the analyzer discretely quantifying the code signal intensities by comparison to the reference intensity of the label.

8. The identification system of claim 7, wherein the code signal intensities define discrete ratios with the associated reference intensities.

9. The identification system of claim 7, wherein, for each label, the reference intensity comprises at least one member selected from a group consisting of: a highest intensity of the spectra, a lowest intensity of the spectra, a shortest wavelength peak of the spectra, and a longest wavelength peak.

10. The identification system of claim 1, wherein at least some of the reference signals of the labels have common reference wavelengths.

11. The identification system of claim 1, where the reference signals of at least some of the labels have different reference wavelengths.

12. The identification system of claim 11, wherein each reference signal has a reference wavelength, the reference wavelength being a shortest or a longest wavelength of the spectra of the label.

13. The identification system of claim 1, wherein the reference signals have reference wavelengths, and wherein the other signals have other wavelengths, the other wavelengths of each label being discretely quantifiable by reference to the reference wavelength of the label.

14. The identification system of claim 1, wherein the spectrum of a first label comprises signals having a plurality of wavelengths, wherein a spectrum of a second label comprises signals having the plurality of wavelengths, and wherein the analyzer calibrates spectra intensities of the first and second labels based on the reference signals to distinguish the first and second labels.

15. The identification system of claim 1, further comprising at least 1000 labels with associated identifiable elements.

16. The identification system of claim 1, further comprising fewer than 1000 label with associated identifiable elements.

- 1 50. The method of claim 45, wherein the ranges are separated.
- 1 51. The method of claim 50, wherein the ranges are sufficiently
2 separated so that a pair of signals at adjacent discrete wavelengths within adjacent
3 wavelength ranges are sufficiently separated for independent identification of the discrete
4 wavelengths of each signal of the pair.
- 1 52. The method of claim 50, wherein the ranges are separated by more
2 than about 30 nm.
- 1 53. The method of claim 50, wherein each wavelength range includes
2 at least 5 predetermined discrete wavelengths.
- 1 54. The method of claim 53, wherein there are at least three non-
2 overlapping wavelength ranges.
- 1 55. The method of claim 41, further comprising identifying a plurality
2 of elements in response to spectra generated from other labels associated with the
3 elements by selecting wavelength ranges encompassing signals of the spectra, and by
4 determining wavelengths of the signals within the ranges.
- 1 56. The method of claim 55, wherein no more than one signal from
2 each spectrum is disposed within each wavelength range.
- 1 57. The method of claim 55, further comprising establishing
2 predetermined wavelength ranges, the plurality of elements being identified using the
3 predetermined wavelength ranges.
- 1 58. The method of claim 57, further comprising establishing
2 predetermined discrete wavelengths within the predetermined wavelength ranges, the
3 wavelengths of the signals being selected from the predetermined wavelengths.
- 1 59. The method of claim 55, further comprising rejecting labels having
2 excessive overlap between adjacent discrete wavelengths from different adjacent
3 wavelength ranges.

10 identifying the labels in response to the measured peaks.

- 1 82. The method of claim 80, wherein each predetermined minimum
- 2 wavelength separation is at least as large as a full width half maximum (FWHM) of at
- 3 least one of the associated first peak and the associated second peak.